

Notice of References Cited

Application/Control No.

10/806,172

Applicant(s)/Patent Under
Reexamination
OYABU ET AL.

Examiner

DAVID P. RASHID

Art Unit

2624

Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,461,704	10-1995	Wakabayashi et al.	358/1.15
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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